

Search Notes

Application/Control No.

10/692,241

Examiner

Matthew J. Kaszlejna

Applicant(s)/Patent under
Reexamination

PHAN, HUY D.

Art Unit

3739

SEARCHED

Class	Subclass	Date	Examiner
updated	all	8/8/2005	MJK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR